

Abstract: EN10084 Steel (20MnCr5) is widely known for its superior tensile strength and has therefore been a material of choice in several automotive applications, including gears, axles & pistons. Surface enhancement of metal parts, including grinding, shot peening & finishing, introduces beneficial stresses and surface conditions which can further improve performance attributes. *The purpose of this study is to gain a deeper understanding of the effects on select/controlled surface processing of 20MnCr5 by analyzing, testing & modeling 20MnCr5 samples, for "new" automotive applications including EV's.*

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Project Background

- Our team aimed to characterize the effect of varying **shot peening media types** on the **surface and mechanical properties** of **carburized 20MnCr5 steel strips**
- 20MnCr5 steel strips** allow engineers to model property changes to characterize the effects over the entire treated part
- Shot peening** imparts **compressive residual stress (CRS)** that affects **surface and mechanical properties** (finish, hardness, fatigue)
- Carburization** hardens the surface through carbon diffusion
- Superfinishing (SF)** creates super polished surfaces with low roughness

EI Shot Peening Machine

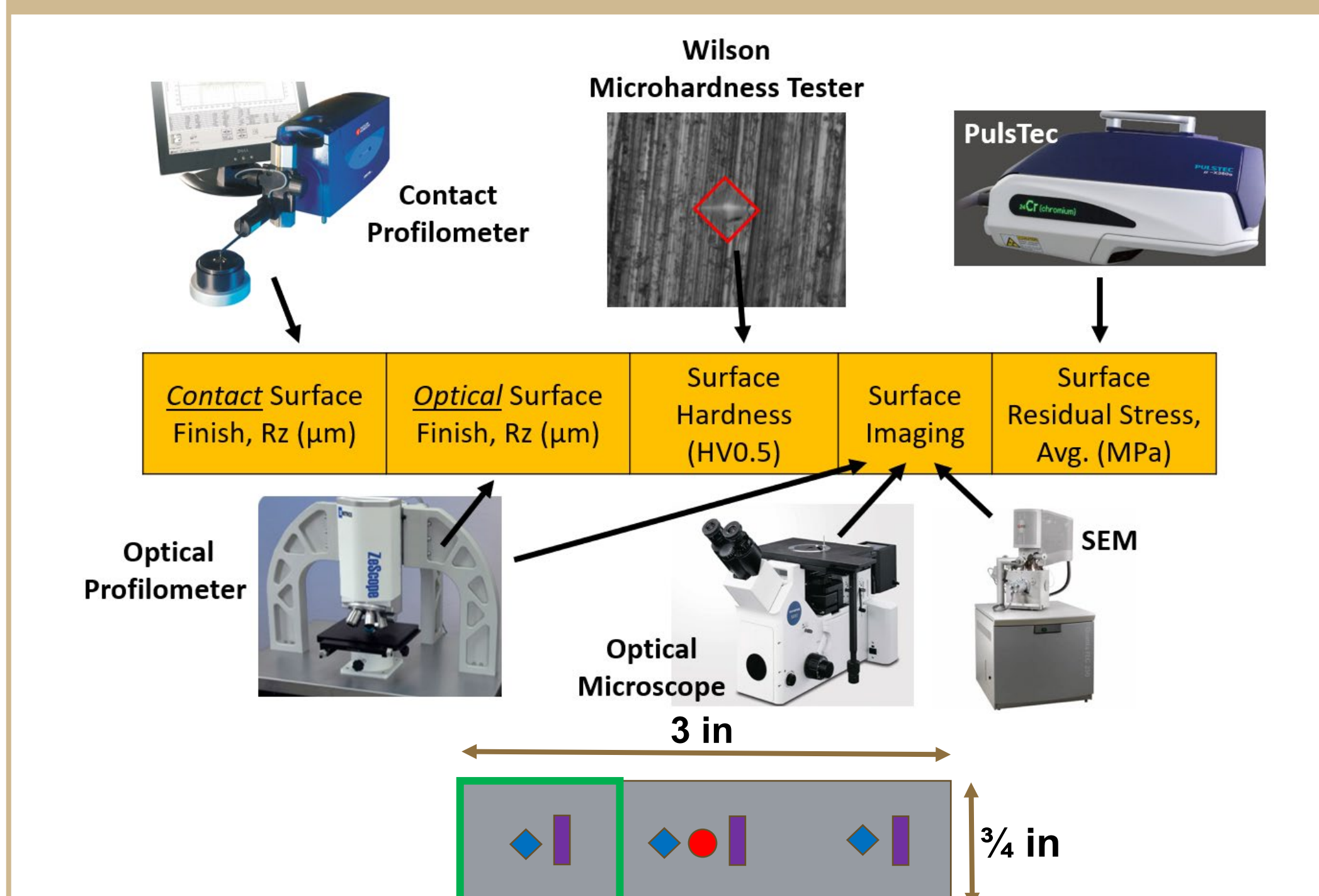
Short-Hand Notation	Peening Regime	Peening Media	Nozzle Pressure (psi)
NP	Nominal Peen	S-170 H	35 psi
FP S-70	Fine Peen	S-70 Hard	95 psi
FP CCW-14	Fine Peen	CCW-14	95 psi
DP	Dual Peen	S-230/AGB-35	40 psi/22 psi



Main Project Objectives

- Is it possible to obtain the **same standard compressive residual stress with a smoother surface finish** without post-processing?
- Can the effects of the **surface processing parameters be modeled or connected to the measurements collected?**

Experimental Techniques



Experimental Testing and Location:

- Residual Stress** with Electro-etching (PulsTec XRD)
- Surface Finish Testing** (Contact and Optical Profilometer)
- Hardness Testing** (Wilson Microhardness Indenter)
- Surface Imaging** (SEM and Optical Microscope)

1. Residual Stress with Electro-etching (PulsTec XRD)

- Apply a current load through salt water to etch away the surface
- Measure residual stress using x-ray diffraction throughout the depth profile

2. Surface Finish Testing (Contact and Optical Profilometer)

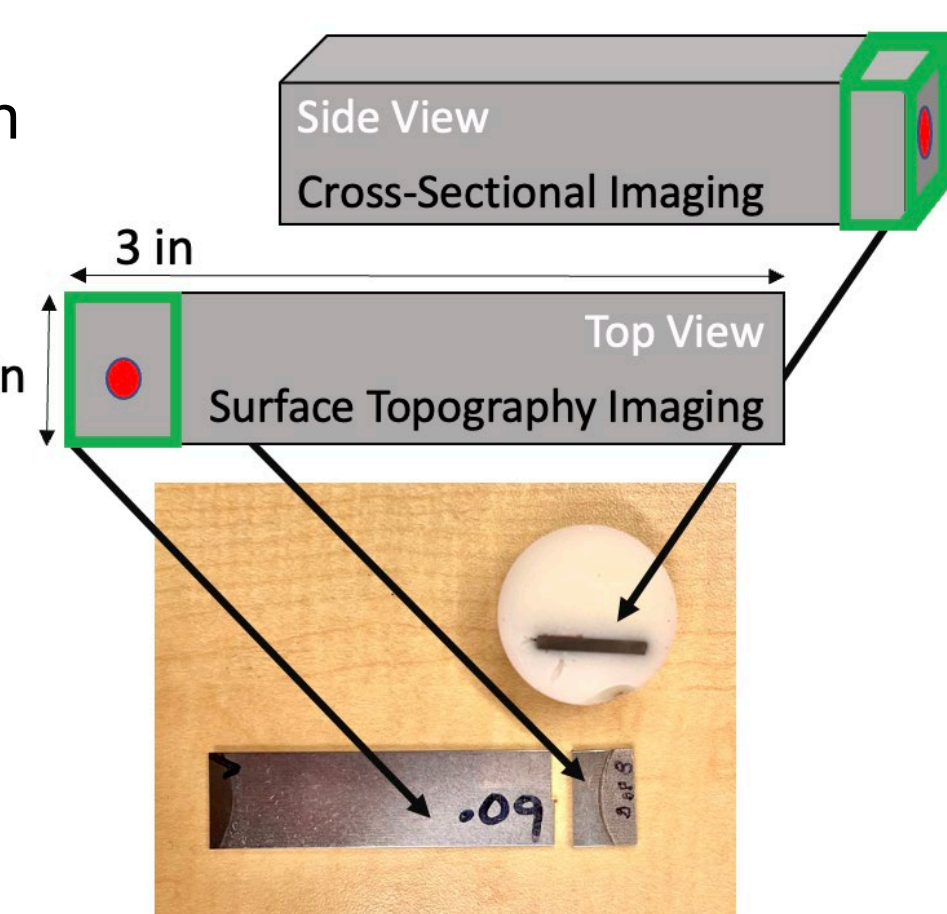
- Contact:** 6 scans of length 5 mm were taken, with the stylus moving 0.1 mm/s with a sampling rate of 50 Hz
- Optical:** 3 scans of 900 by 700 μm were taken in the center of the strips

3. Hardness Testing (Wilson Microhardness Indenter)

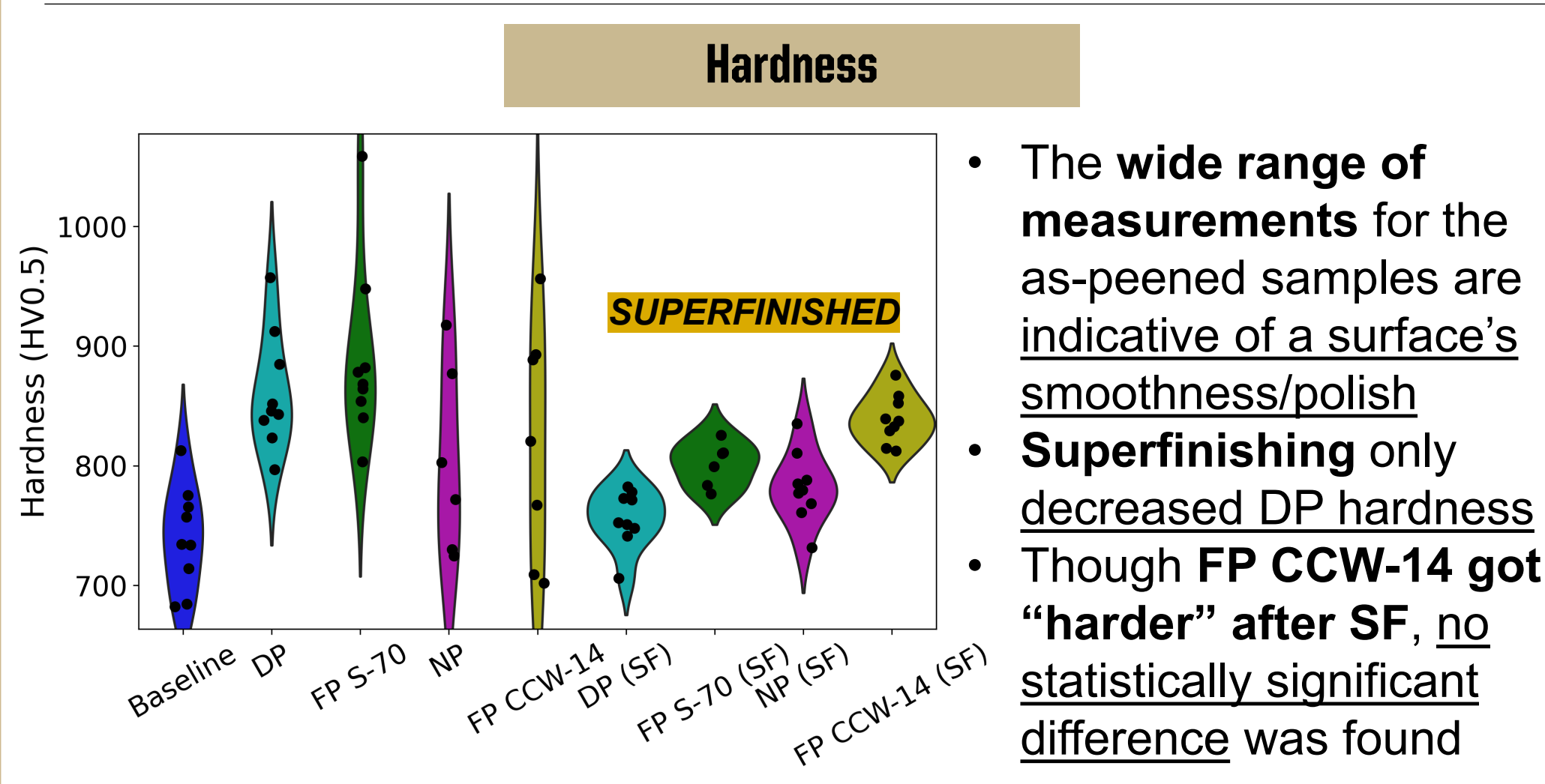
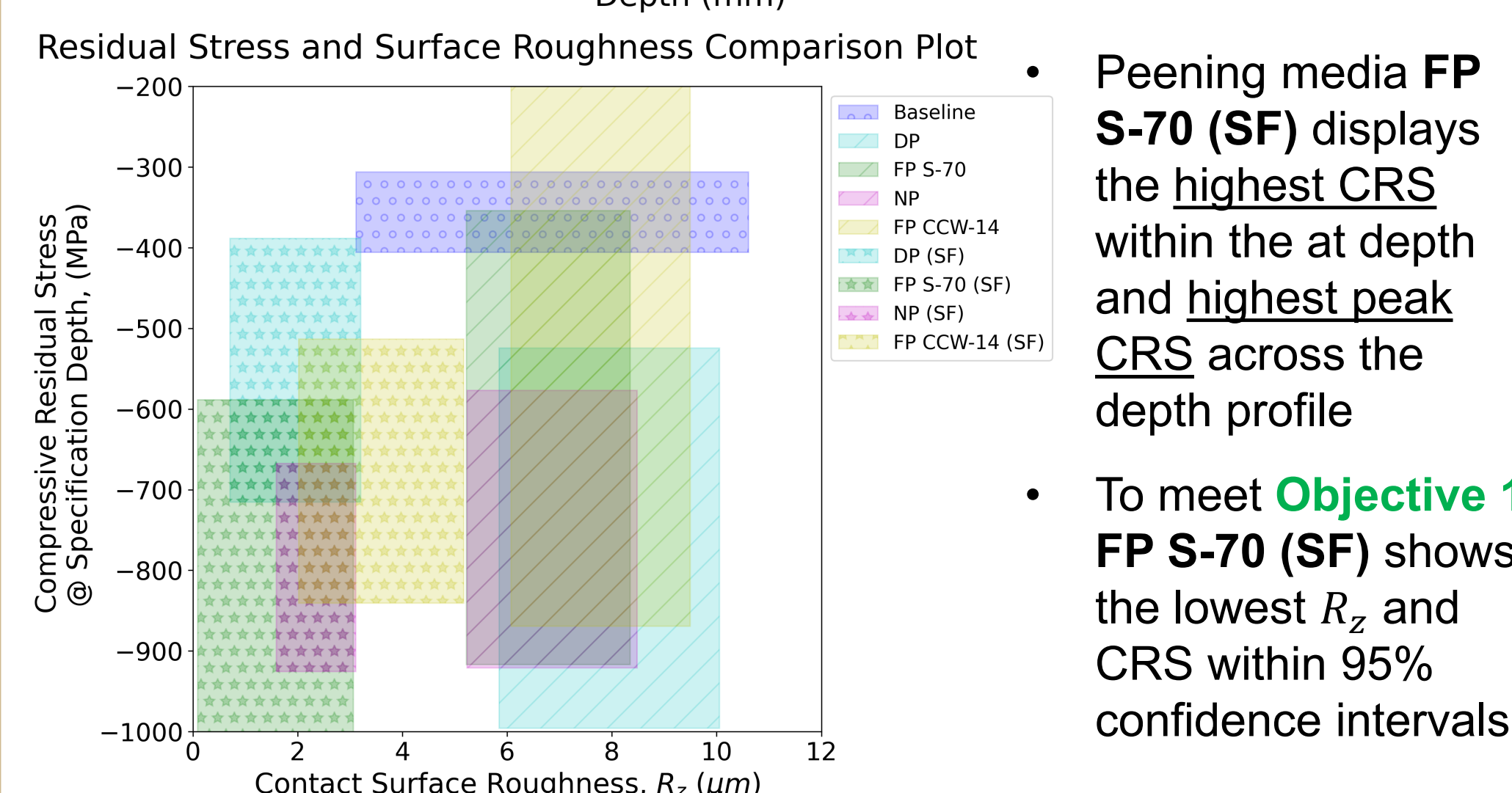
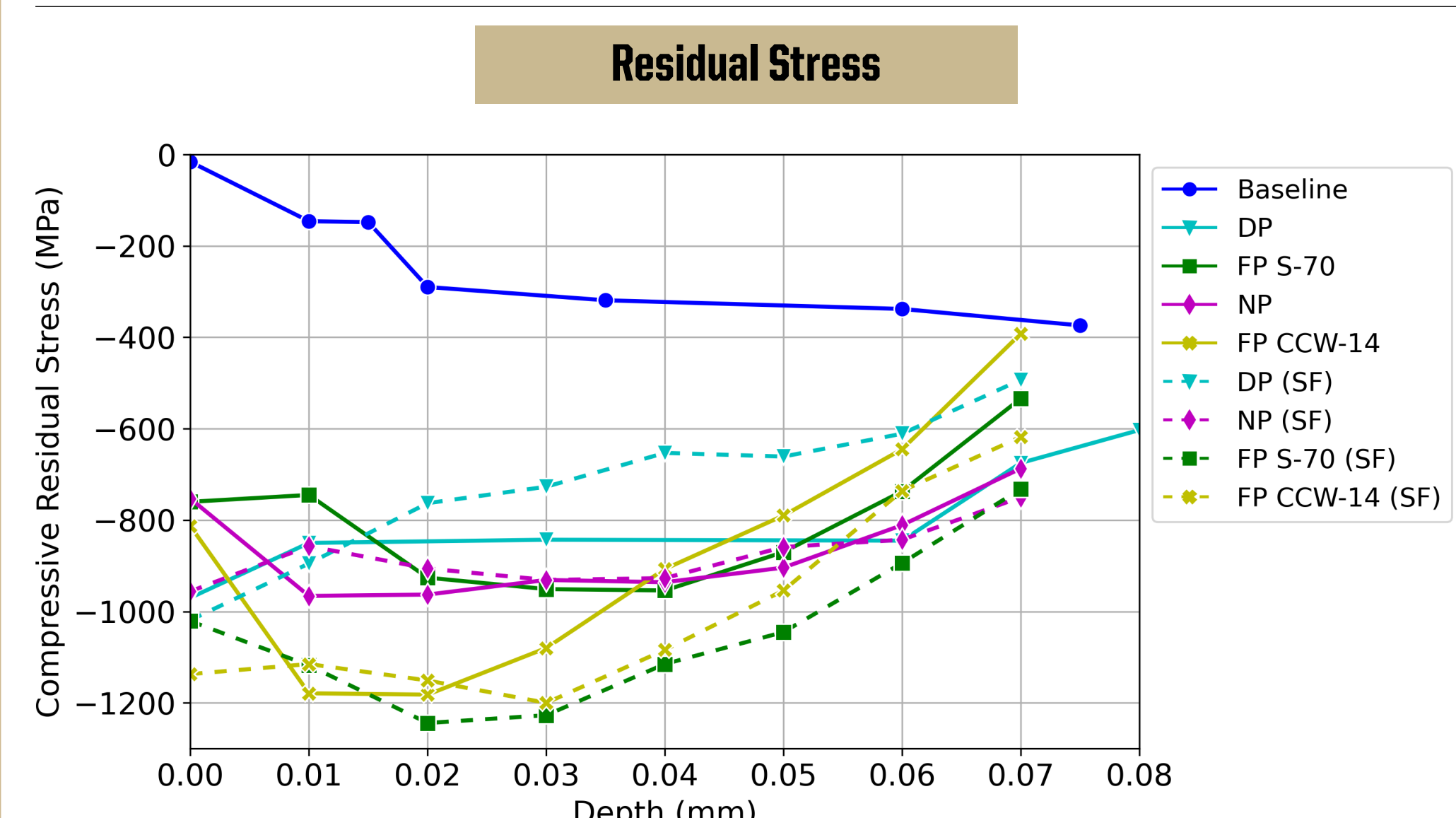
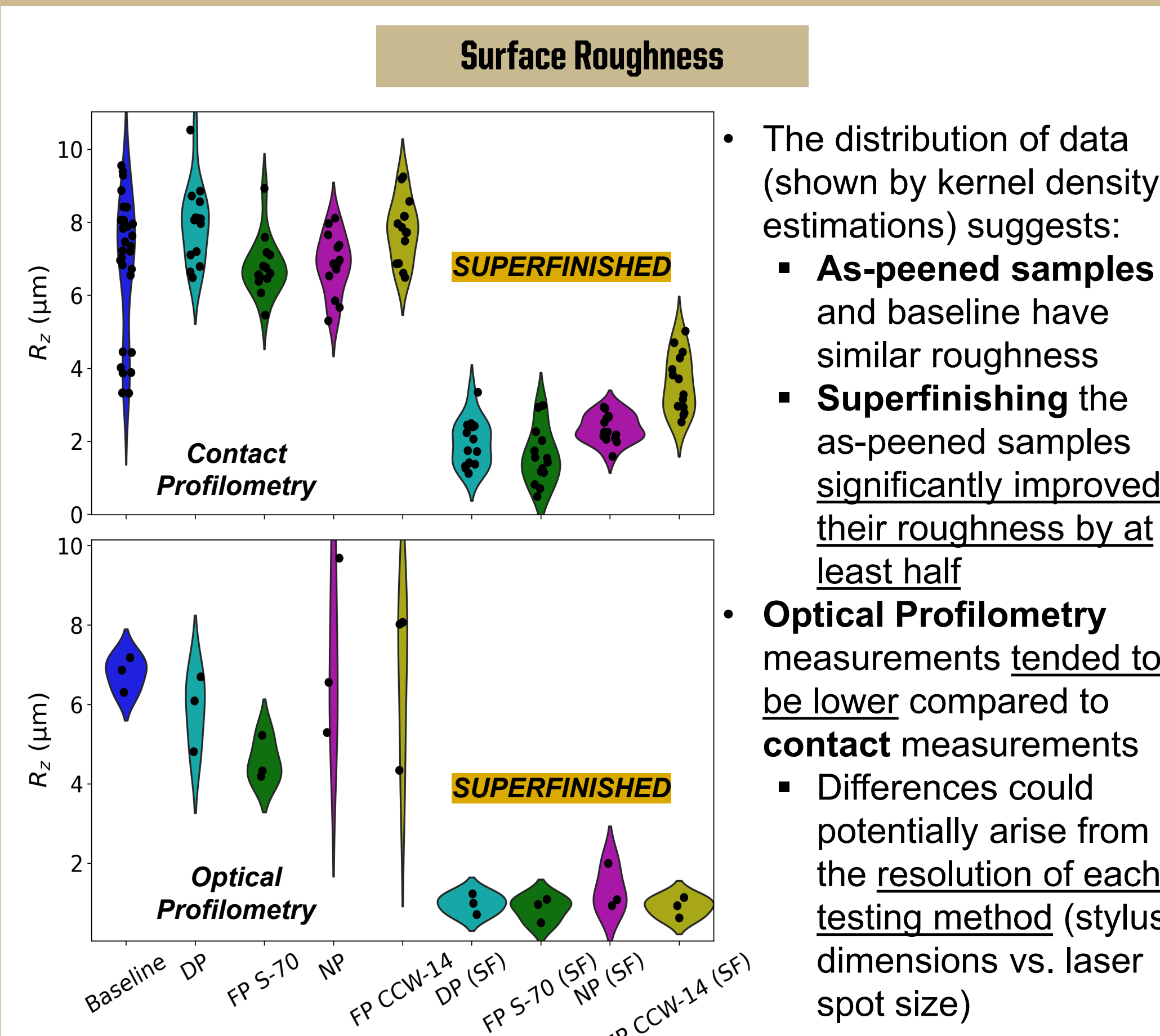
- Used a Vickers tip with a 500g load applied for 10 s
- Indented the non-prepared surface that was peened

4. Surface Imaging (SEM & Optical Microscope)

- SEM** – Secondary electron imaging done on Quanta 650 FEG SEM
- Optical Microscopy** – Olympus-GX51, metallurgically prepared & polished up to a 6 μm surface finish



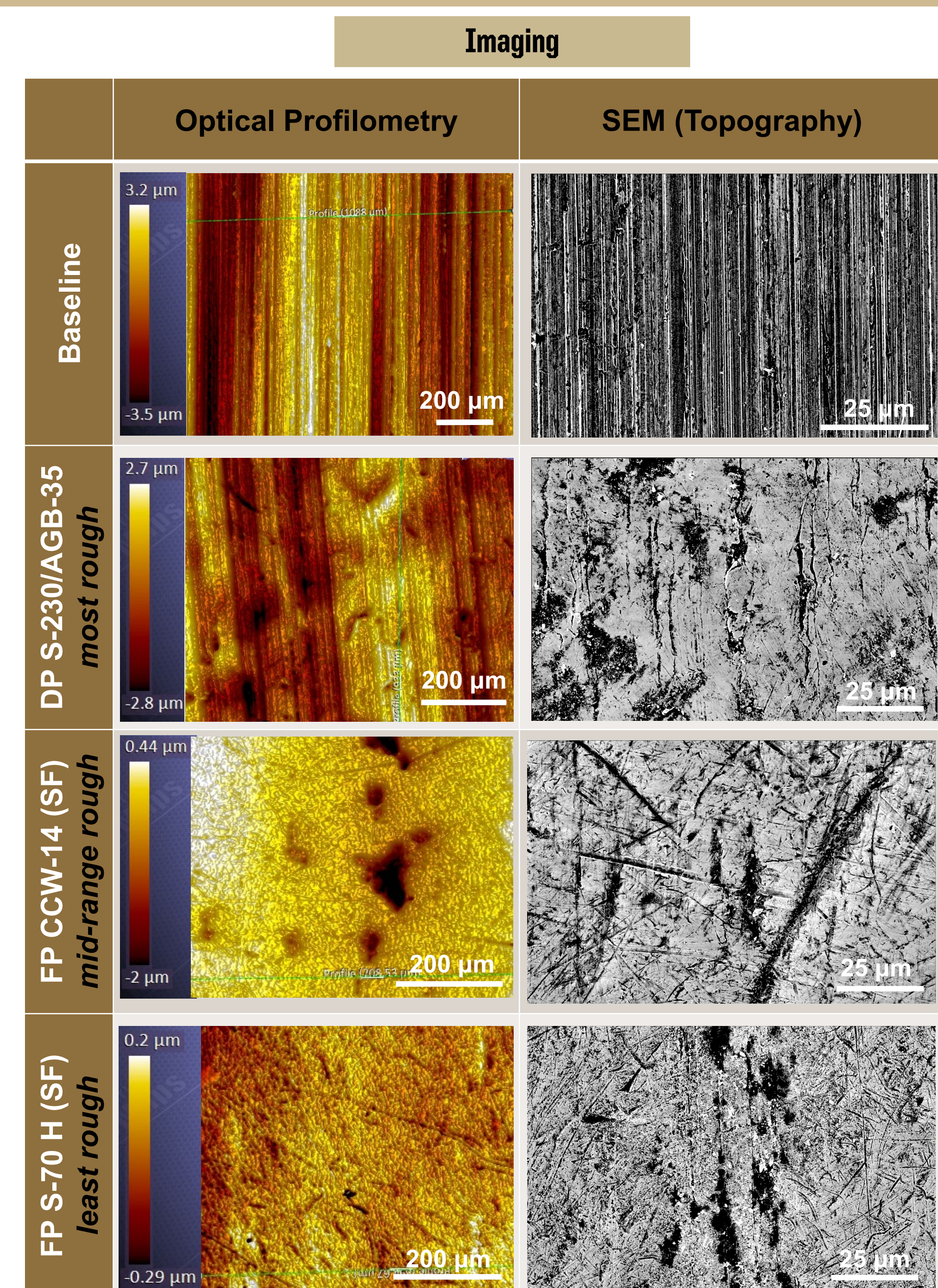
Results & Discussion



Results Summary

Sample Type	Characterization				
	Contact Surface Finish, R_z (μm)	Optical Surface Finish, R_z (μm)	Surface Hardness (HV0.5)	Surface Imaging	Surface Residual Stress, Avg. (MPa)
Baseline	6.86 (n=28)	6.79 (n=3)	740 (n=9)	(n=2)	-356 (n=2)
DP	7.95 (n=14)	5.87 (n=3)	861 (n=9)	(n=2)	-760 (n=2)
FP S-70	6.79 (n=14)	4.58 (n=3)	889 (n=9)	(n=2)	-635.5 (n=2)
NP	6.86 (n=14)	7.18 (n=3)	804 (n=6)	(n=2)	-749 (n=2)
FP CCW-14	7.79 (n=14)	6.81 (n=3)	819 (n=7)	(n=2)	-518.5 (n=2)
DP (SF)	1.96 (n=14)	0.98 (n=3)	756 (n=9)	(n=1)	-552 (n=2)
FP S-70 (SF)	1.58 (n=14)	0.85 (n=3)	801 (n=6)	(n=2)	-813 (n=2)
NP (SF)	2.35 (n=14)	1.34 (n=3)	782 (n=9)	(n=1)	-796.5 (n=2)
FP CCW-14 (SF)	3.60 (n=14)	0.90 (n=3)	839 (n=9)	(n=2)	-677 (n=2)

Results & Discussion



SEM & Optical Profilometry imaging suggest:

- Baseline** topography showed **grinding striations** which are representative of a **pre-peened surface**
- Dual peening** had the largest impact on surface topography and roughness with **folding and flattening** of striations, which are likely caused by two peening medias (S-230/AGB-35)
- SF samples** showed **shorter** and more **isolated striations** than as-peened samples
- SF samples** showed less **folding and flattening** of striations, likely caused by **polishing** after the peening process

Conclusions

	OBJECTIVE 1: Same compressive residual stress with a smoother surface finish	OBJECTIVE 2: Connecting surface processing parameters to the measurements
Surface Roughness	<ul style="list-style-type: none"> FP S-70 (SF) shows both highest CRS at depth & smoothest surface finish SF samples had significantly smoother surface As-peened samples resulted in similar surface roughness compared to the baseline set 	<ul style="list-style-type: none"> Varying the peening regime did not create noticeable differences in the as-peened samples' surface roughness SF process helped to reduce roughness by at least half
Residual Stress	<ul style="list-style-type: none"> As-peened samples showed an increased CRS compared to the baseline set Superfinished NP set gave a smoother finish, but did not change the stress profile 	<ul style="list-style-type: none"> Peening the surface increased compressive residual stress (CRS) at targeted depth
Surface Imaging	<ul style="list-style-type: none"> FP S-70 (SF) visually proved to have the smoothest surface with the least peening striations & the greatest mean CRS 	<ul style="list-style-type: none"> SF topography had fewer grind striations and impact spots compared to as-peened samples – which are also reflected in optical and contact profilometry results
Surface Hardness	<ul style="list-style-type: none"> Hardness trends generally matched CRS trends between all samples 	<ul style="list-style-type: none"> Large standard deviations (or wide range) from as-peened samples indicate the irregularity in surface finish

Acknowledgements

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